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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/052,024	01/18/2002	Dawn A. Bonnell	UPN-4110	1230	
7590 12/01/2003 Woodcock Washburn LLP			EXAMINER		
			BENSON, WALTER		
One Liberty Pla Philadelphia, P	ace - 46th Floor PA 19103		ART UNIT	PAPER NUMBER	
- ······, -			2858 DATE MAILED: 12/01/200	2	

Please find below and/or attached an Office communication concerning this application or proceeding.

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•		Appl	ication No.	Applicant(s)	<i>y</i> v				
Office Action Commons		10/0	52,024	BONNELL ET AL.					
•	Office Action Summary	Exar	niner	Art Unit					
_ <u></u>			er Benson	2858					
Period fo	The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply								
THE - Exte after - If the - If NO - Failu - Any	ORTENED STATUTORY PERIOD MAILING DATE OF THIS COMMU nsions of time may be available under the provision SIX (6) MONTHS from the mailing date of this corporate period for reply specified above is less than thirty period for reply is specified above, the maximum tre to reply within the set or extended period for rereply received by the Office later than three monthed patent term adjustment. See 37 CFR 1.704(b).	NICATION. Ins of 37 CFR 1.136(a). In Inmunication. In the statutory period will apply In the statutory period will apply In the statute, cause to In the statute, cause to In the statute and the statute and the statute.	no event, however, may the statutory minimum of t and will expire SIX (6) M the application to become	a reply be timely filed hirty (30) days will be considered timel ONTHS from the mailing date of this o ABANDONED (35 U.S.C. § 133).	y. ommunication.				
1)🛛	Responsive to communication(s) to	iled on <u>e<i>lection file</i></u>	ed 9/17/03.						
2a) <u></u> ☐	This action is FINAL .	2b)⊠ This action	is non-final.						
3)	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.								
Disposition of Claims									
 4) Claim(s) 1-20 is/are pending in the application. 4a) Of the above claim(s) 1-7 and 20 is/are withdrawn from consideration. 5) Claim(s) is/are allowed. 6) Claim(s) 8.9,13 and 15 is/are rejected. 7) Claim(s) 10-12,14 and 16-19 is/are objected to. 8) Claim(s) are subject to restriction and/or election requirement. 									
Application Papers									
9)☐ The specification is objected to by the Examiner.									
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.									
	Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).								
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).									
11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.									
Priority under 35 U.S.C. §§ 119 and 120 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).									
* 5 13)⊠ / s 3 2 14)□ /	Acknowledgment is made of a cla All b) Some * c) None of 1. Certified copies of the priori 2. Certified copies of the priori 3. Copies of the certified copie application from the Interna See the attached detailed Office ac Acknowledgment is made of a clain ince a specific reference was included 7 CFR 1.78. a) The translation of the foreign Acknowledgment is made of a clain eference was included in the first see	ty documents have ty documents have es of the priority do tional Bureau (PC ⁻ tion for a list of the n for domestic prior ded in the first sent language provision n for domestic prior	e been received. be been received in cuments have been received in cuments have been received in a 17.2(a)). certified copies notity under 35 U.S. dence of the special application has rity under 35 U.S.	Application No en received in this National of received. C. § 119(e) (to a provisional fication or in an Application been received. C. §§ 120 and/or 121 since	al application) Data Sheet. a specific				
Attachmer	nt(s)								
1) Notice 2) Notice	ce of References Cited (PTO-892) ce of Draftsperson's Patent Drawing Review mation Disclosure Statement(s) (PTO-1449			w Summary (PTO-413) Paper Not of Informal Patent Application (PTo					

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DETAILED ACTION

Election/Restrictions

1. Applicant's election with traverse of claims 8-19 in Paper No. 8 is acknowledged. The traversal is on the ground(s) that claims 1-19 are amenable to be examined without imposing serious burden by the examiner. This is not found persuasive because a generic claim in a species requirement does not require examination of all claims that dependent on the generic claim. Only those claims directed to the elected species will be examined.

The requirement is still deemed proper and is therefore made FINAL.

2. Claims 1-7 and 20 are withdrawn from further consideration pursuant to 37 CFR 1.142(b), as being drawn to a nonelected species, there being no allowable generic or linking claim. Applicant timely traversed the restriction (election) requirement in Paper No. 8.

Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

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- 4. Claims 8, 9, 13, and 15 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hellemans et al. (US Patent No. 6,201,401 B1 and Hellemans hereinafter) in view of Adderton et al. (US Patent No. 6,530,266 B1 and Adderton hereinafter).
- 5. As to claim 8, Hellemans discloses a method for determining impedance information of an interface in a sample substantially as claimed, the method comprising:

applying an ac voltage to the sample, laterally across the interface, the ac voltage having a predetermined frequency (col. 7, lines 25-28 and col. 9, lines 20-24);

disposing a cantilevered tip in a first position proximate to a surface of the sample (12, Fig. 4; col. 7, lines 49-54);

measuring a first response of the cantilevered tip with the cantilevered tip in the first position (col. 7, lines 54-58);

placing the cantilevered tip in a second position proximate to the surface of the sample, the interface being between the first position and the second position (col. 8, lines 1-9;

measuring a second response of the cantilevered tip with the cantilevered tip in the second position (Fig. 5; col. 8, lines 10-13);

Hellemans did not expressly disclose:

determining impedance information of the interface based upon the measured first response and the measured second response.

Nonetheless, these features are well known in the art and would have been an obvious modification of the system disclosed by Hellemans, as evidenced by Adderton.

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In an analogous art, Adderton discloses an active probe for an Atomic Force Microscope having:

determining impedance information of the interface based upon the measured first response and the measured second response (col. 8, lines 59-67).

Given the teaching of Adderton, a person having ordinary skill in the art at the time of the invention would have readily recognized the desirability and advantages of modifying Hellemans by employing the well known or conventional features of image and position topography measurements, such as disclosed by Adderton, in order to detect changes in the oscillation amplitude of the cantilever tip indicative of a particular surface topography.

6. As to claims 9, 13, and 15, Adderton discloses a method for determining impedance information of an interface in a sample, the method comprising:

measuring a first response comprises measuring a first phase angle of deflection of the cantilevered tip (col. 11, lines 59-67);

measuring a second response comprises measuring a second phase angle of deflection of the cantilevered tip (col. 11, lines 63-67);

determining impedance information comprises: determining a phase shift based upon the first phase angle and the second phase angle (col. 12, lines 47-49);

determining impedance information of the interface based upon the phase shift and the frequency of the ac voltage (col. 11, lines 56-62).

Given the teaching of Adderton, a person having ordinary skill in the art at the time of the invention would have readily recognized the desirability and advantages of modifying Hellemans

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by employing the well known or conventional features of image and position topography measurements, such as disclosed by Adderton, in order to realize high quality images at fast imaging speeds for a particular surface topography.

Allowable Subject Matter

7. Claims 10-12, 14, and 16-19 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims. The prior art of record fails to teach or suggest individually or in combination and a device and method for topographic processes where the step of determining impedance information further comprises determining an impedance product of the interface according to:

$$\tan(\varphi_{gb}) = \frac{\omega C_{gb} R_{gb}^2}{\left(R + R_{gb}\right) + R\omega^2 C_{gb}^2 R_{gb}^2}$$

where Cgb is the capacitance of the interface;

Rab is the resistance of the interface;

is the frequency of the ac voltage;

b is the phase shift;

R is a resistance of a current limiting resistor in series with the sample.

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Prior Art Made of Record

8. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure

A. Jackson (US 2002/0021139) discloses a method and apparatus for measuring an electrical characteristic on a molecular scale;

B. Ho et al. (US Patent No. 5,847,569) discloses a method and apparatus for measuring at least one parameter of material with sub-micron spatial resolution.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Walter Benson whose telephone number is (703) 306-4525. The examiner can normally be reached on Mon to Fri 6:30 AM to 4:00 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, N. Le can be reached on (703) 308-0750. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 305-4900.

Walter Benson Ratent Examiner
November 25, 2003

Supervisory Patent Examiner Technology Center 2800